19-1140; Rev 0; 9/96

MAXIM

Low-Power, +2.5V to +5.5V, 8-Bit Voltage-Output DAC in µMAX

MAX550B

General Description

The MAX550B serial, 8-bit, voltage-output, digital-to-analog converter (DAC) operates on a single +2.5V to +5.5V supply. Its ±1LSB TUE specification is guaranteed over temperature. Operating current (supply current plus reference current) is typically 75µA with V_{DD} = 2.5V and less than 1µA in shutdown mode. The reference input is disconnected from the REF pin during shutdown.

The serial interface operates at clock rates up to 10MHz and is compatible with 3-wire SPI™, QSPI™, and Microwire™ interface standards.

The MAX550B's ultra-low power consumption and small µMAX package make it ideal for portable and battery-powered applications.

Applications

VCXO Control

Comparator Level Settings

GaAs Amp Bias Control

Digital Gain and Offset Control

Features

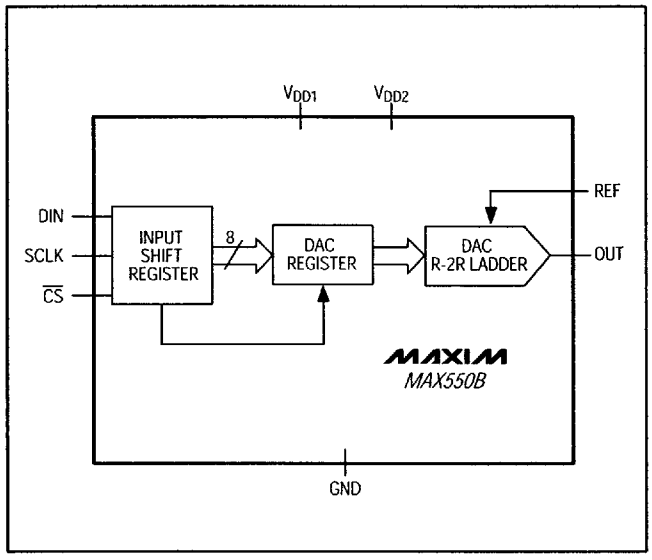
- **+2.5V to +5.5V Single-Supply Operation**
- **±1LSB (max) TUE**
- **Low 75µA Operating Current (V_{DD} = +2.5V)**
- **1µA Shutdown Mode**
- **µMAX Package—50% Smaller than 8-Pin SO**
- **10MHz, 3-Wire Serial Interface**
- **Internal Power-On Reset Clears All Registers to Zero**

Ordering Information

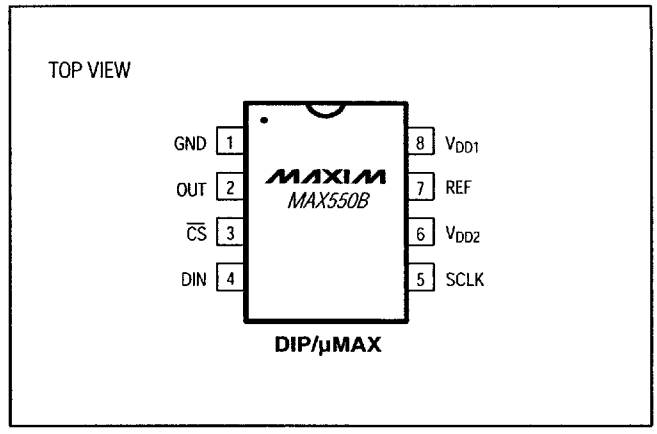
PART	TEMP. RANGE	PIN-PACKAGE
MAX550BCPA	0°C to +70°C	8 Plastic DIP
MAX550BCUA	0°C to +70°C	8 µMAX
MAX550BC/D	0°C to +70°C	Dice*
MAX550BEPA	-40°C to +85°C	8 Plastic DIP
MAX550BEUA	-40°C to +85°C	8 µMAX

Dice are specified at T_A = +25°C, DC parameters only.

Functional Diagram



Pin Configuration



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Microwire is a registered trademark of National Semiconductor Corp.

Low-Power, +2.5V to +5.5V, 8-Bit Voltage-Output DAC in µMAX

ABSOLUTE MAXIMUM RATINGS

V_{DD1}, V_{DD2}, SCLK, D_{IN}, $\overline{CS}$, OUT to GND .....-0.3V to +6V
REF .....-0.3V to ($V_{DD\_}$ + 0.3V)
Maximum Current (any pin) 50mA
Continuous Power Dissipation (T_A = +70°C)
Plastic DIP (derate 9.1mW/°C above +70°C) 727mW
µMAX (derate 4.1mW/°C above +70°C) 330mW

Operating Temperature Ranges
MAX550BBC_A .....0°C to +70°C
MAX550BBE_A .....-40°C to +85°C
Storage Temperature Range .....-65°C to +150°C
Lead Temperature (soldering, 10sec) .....+300°C

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

ELECTRICAL CHARACTERISTICS

(V_{DD1} = V_{DD2} = +2.5V to +5.5V, T_A = T_{MIN} to T_{MAX}, unless otherwise noted. Typical values are at T_A = +25°C.)

PARAMETER	SYMBOL	CONDITIONS		MIN	TYP	MAX	UNITS
STATIC PERFORMANCE							
Resolution	N			8			Bits
Differential Nonlinearity	DNL	Guaranteed monotonic	MAX550BBC_A/MAX550BBE			±0.9	LSB
			MAX550BBEUA (Note 1)			±0.9	
Total Unadjusted Error	TUE		MAX550BBC_A/MAX550BBE			±1	LSB
			MAX550BBEUA (Note 1)			±1	
Zero-Code Error	ZCE	T_A = +25°C				±1	LSB
Full-Scale Error	FSE					±1	LSB
REFERENCE INPUT							
Reference Input Voltage	V_{REF}	For specified performance		2.5		V_{DD}	V
Reference Input Resistance (Note 2)	R_{REF}	DAC code = 55 hex			32		kΩ
Reference Input Current (Note 3)	I_{REF}	DAC code = 55 hex	$V_{DD\_}$ = V_{REF} = 5.5V		160	275	µA
			$V_{DD\_}$ = V_{REF} = 2.5V		75	125	
DAC OUTPUT (OUT)							
DAC Output Voltage Swing				0		V_{REF}	V
DAC Output Resistance	R_{OUT}				32		kΩ
DIGITAL INPUTS ($\overline{CS}$, SCLK, DIN)							
Input High Voltage	V_{IH}			0.7$V_{DD_}$			V
Input Low Voltage	V_{IL}					0.3$V_{DD_}$	V
Input Current	I_{IN}	V_{IN} = 0V or $V_{DD\_}$				±1	µA
Input Capacitance (Note 4)	C_{IN}					10	pF

ELECTRICAL CHARACTERISTICS (continued)

(V_{DD1} = V_{DD2} = +2.5V to +5.5V, T_A = T_{MIN} to T_{MAX}, unless otherwise noted. Typical values are at T_A = +25°C.)

PARAMETER	SYMBOL	CONDITIONS		MIN	TYP	MAX	UNITS
DYNAMIC PERFORMANCE							
Digital Feedthrough and Crosstalk		$\overline{CS}$ = high, all digital inputs from 0V to $V_{DD\_}$			50		nV-sec
Voltage-Output Settling Time		To ±1/2LSB, C_L = 20pF			4		µs
Voltage-Output Slew Rate	SR	C_L = 20pF	$V_{DD\_}$ = 2.5V		1.4		V/µs
			$V_{DD\_}$ = 5.5V		3.1		
Wake-Up Time		C_{LOAD} = 20pF			4		µs
POWER SUPPLIES							
Supply Voltage Range	$V_{DD\_}$	Output unloaded, all inputs = GND or V_{DD}		2.5		5.5	V
Supply Current	I_{DD1} + I_{DD2}	$V_{DD\_}$ = 5.5V, output unloaded, all inputs = GND or $V_{DD\_}$			0.3	10	µA
Shutdown Current		Shutdown mode			0.3		µA

Note 1: 0°C to -40°C testing guaranteed by design using six sigma design limits.
Note 2: Worst-case input resistance at REF occurs at DAC code 55 hex.
Note 3: Worst-case reference input current occurs at DAC code 55 hex.
Note 4: Guaranteed by design. Not production tested.

TIMING CHARACTERISTICS (Note 5)

(V_{DD1} = V_{DD2} = +2.5V to +5.5V, T_A = T_{MIN} to T_{MAX}, unless otherwise noted. Digital inputs switching from 0V to $V_{DD\_}$.)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
SCLK Pulse Width High	t_{CH}		40			ns
SCLK Pulse Width Low	t_{CL}		40			ns
DIN to SCLK High Setup	t_{DS}		30			ns
DIN to SCLK High Hold	t_{DH}	$V_{DD\_}$ = 2.5V	0			ns
		$V_{DD\_}$ = 5.5V	10			
$\overline{CS}$ Low to SCLK High Setup	t_{CSS0}		30			ns
$\overline{CS}$ High to SCLK High Setup	t_{CSS1}		30			ns
SCLK High to $\overline{CS}$ Low Hold	t_{CSH0}		20			ns
Delay, SCLK High to $\overline{CS}$ High	t_{CSH1}	$V_{DD\_}$ = 2.5V	10			ns
		$V_{DD\_}$ = 5.5V	20			
$\overline{CS}$ Pulse Width High	t_{CSW}		40			ns
SCLK Period	t_{CP}		80			ns
$V_{DD\_}$ High to $\overline{CS}$ Low		Power-on reset delay		5		µs

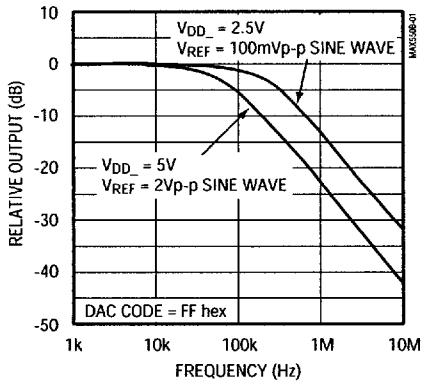
Note 5: Guaranteed by design. Not production tested.

Low-Power, +2.5V to +5.5V, 8-Bit Voltage-Output DAC in µMAX

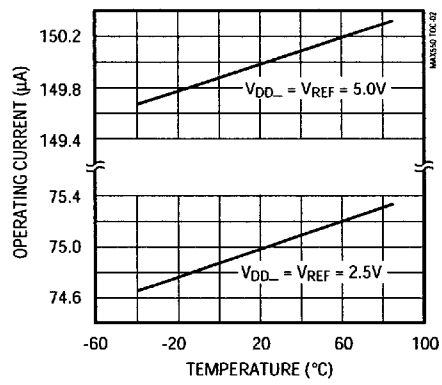
Typical Operating Characteristics

(V_{DD1} = V_{DD2} = 2.5V, V_{REF} = $V_{DD\_}$, R_L = 1MΩ, C_L = 15pF, T_A = +25°C, unless otherwise noted.)

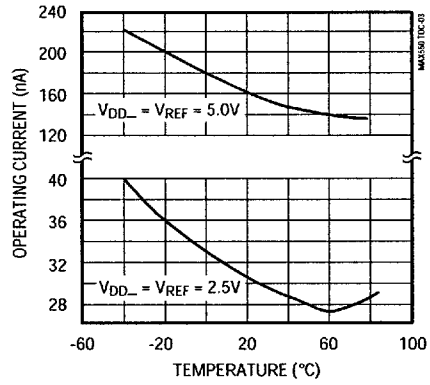
REFERENCE FREQUENCY RESPONSE



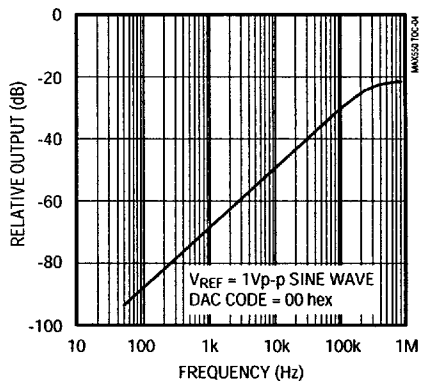
OPERATING CURRENT vs. TEMPERATURE



SHUTDOWN CURRENT vs. TEMPERATURE



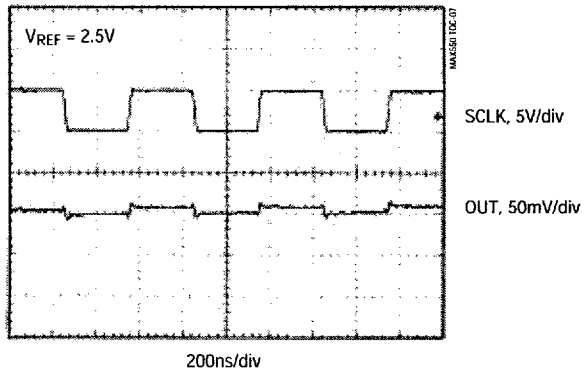
REFERENCE AC FEEDTHROUGH vs. FREQUENCY



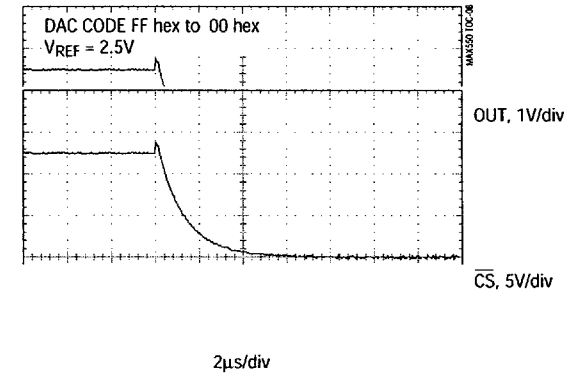
Typical Operating Characteristics (continued)

(V_{DD1} = V_{DD2} = 2.5V, V_{REF} = $V_{DD\_}$, R_L = 1MΩ, C_L = 15pF, T_A = +25°C, unless otherwise noted.)

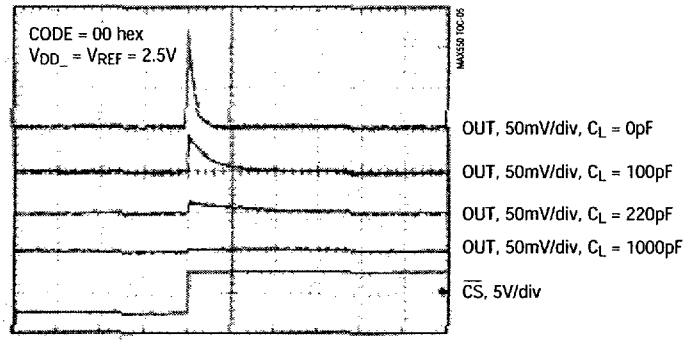
DIGITAL FEEDTHROUGH



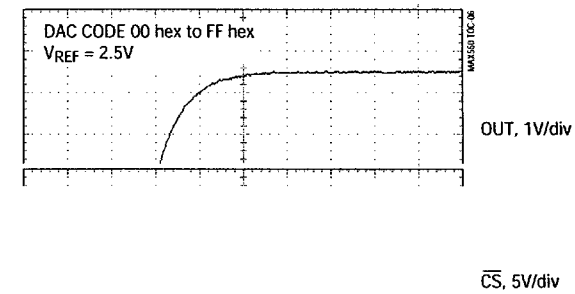
NEGATIVE SETTLING TIME



OUTPUT GLITCH FILTERING



POSITIVE SETTLING TIME



Low-Power, +2.5V to +5.5V, 8-Bit Voltage-Output DAC in µMAX

Pin Description

PIN	NAME	FUNCTION
1	GND	Ground
2	OUT	DAC Output Voltage
3	$\overline{CS}$	Chip-Select Input. A logic low on $\overline{CS}$ enables serial data to be clocked into the input shift register. Programming commands are executed at $\overline{CS}$'s rising edge.
4	DIN	Serial Data Input. Data is clocked into the 16-bit input shift register on SCLK's rising edge.
5	SCLK	Serial Clock Input. Data is clocked in on SCLK's rising edge.
6	V_{DD2}	Connect to V_{DD1}
7	REF	External Reference Voltage Input for DAC (2.5V to $V_{DD\_}$)
8	V_{DD1}	Positive Power Supply (+2.5V to +5.5V)

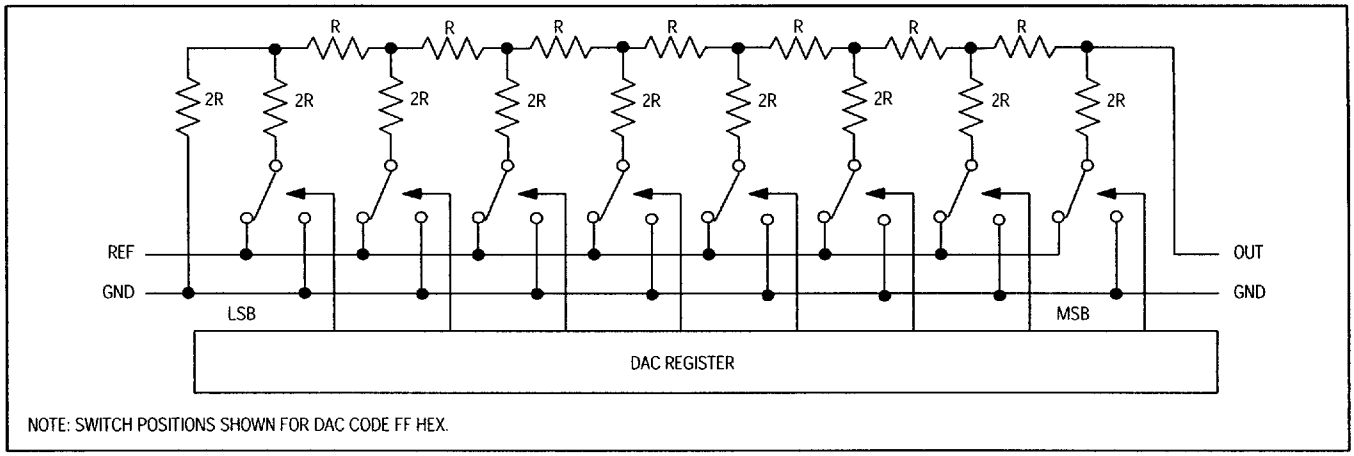


Figure 1. DAC Simplified Circuit Diagram

Detailed Description

Analog Section

The MAX550B is an 8-bit, voltage-output digital-to-analog converter (DAC). The DAC consists of an R-2R ladder network that converts 8-bit digital inputs into equivalent analog output voltages in proportion to the applied reference voltage (Figure 1). The MAX550B's output is unbuffered and has a typical output resistance of 32kΩ. The power-supply range is from +2.5V to +5.5V.

Reference Input

The voltage applied at REF sets the full-scale output for the DAC and may range from 2.5V to $V_{DD\_}$. The REF input resistance is code-dependent, with the lowest value (typically 32kΩ) occurring when the DAC register is loaded with a code of 01010101 (55 hex). To minimize INL errors, the reference voltage source should have less than 6Ω output impedance.

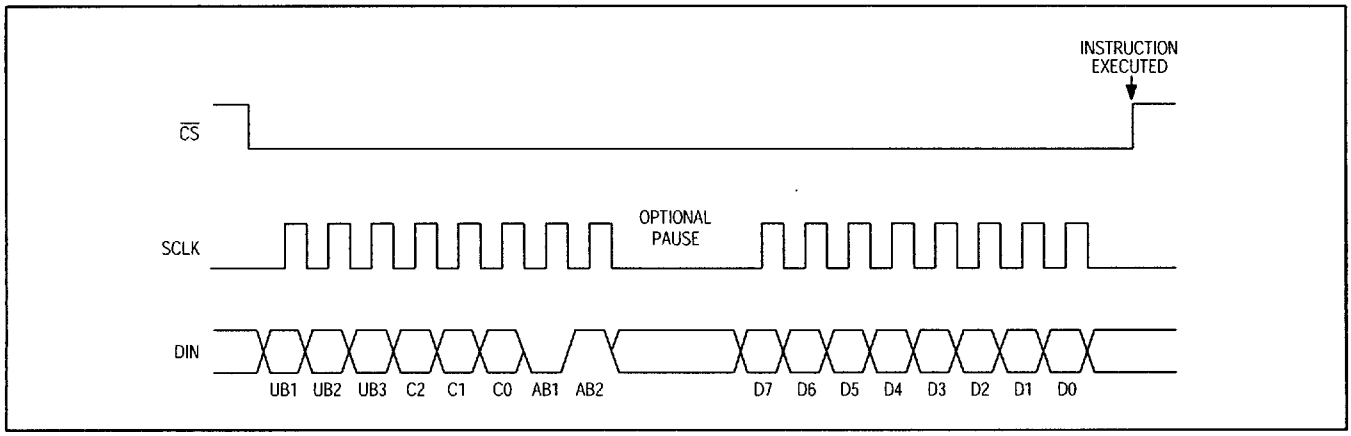


Figure 2. Serial-Interface Timing Diagram

DAC Output

The MAX550B's output is unbuffered; it connects directly to the R-2R ladder. This configuration minimizes power consumption and reduces offset errors. For highest accuracy, apply high resistive loads (1MΩ and up). Lower resistive loads can be driven, but output loading increases full-scale error. The magnitude of the expected error is the ratio of the DAC output resistance to the DC load resistance at the output.

Typically, an energy pulse is coupled into the DAC output on the rising edge of $\overline{CS}$. Since the MAX550B's output is unbuffered (connected directly to the R-2R ladder), connecting a small capacitor (200pF to 1000pF) from the output to ground creates a lowpass filter that effectively suppresses the pulse for sensitive applications (see Output Glitch Filtering graph in the *Typical Operating Characteristics*).

Shutdown Mode

When the MAX550B is in shutdown mode, REF becomes high impedance. The supply current is unchanged, but the REF input current decreases to less than 1µA. This allows the system reference to remain active with minimal power consumption.

When exiting shutdown mode, the output recovery time is equivalent to the DAC settling time.

Serial Interface

The MAX550B interface is compatible with 3-wire SPI™, QSPI™, and Microwire™ microprocessor (µP) interface standards. An active-low chip select ($\overline{CS}$) enables the input shift register to receive data from the serial input, DIN (Figure 2). Data is clocked into the input shift register on rising edges of the serial clock signal (SCLK). The clock frequency can be as high as 10MHz.

When writing to the DAC, transmit data MSB first in one 16-bit word or two 8-bit bytes. The write cycle can be segmented when $\overline{CS}$ is kept active (low) to allow two 8-bit-wide transfers. After clocking all 16 bits into the input shift register, a rising edge on $\overline{CS}$ programs the DAC. The DAC output reflects the data stored in the DAC register. Figure 3 gives detailed timing information.

Initialization

The MAX550B has an internal power-on reset. At power-up, all internal registers are reset to zero; therefore, an initialization write is not necessary.

Serial Input Data Format and Control Codes

The control byte programs the DAC (Table 1). Table 2 lists the MAX550B's serial-input command format. The 16-bit input word consists of an 8-bit control byte and an 8-bit data byte. The 8-bit control byte is not decoded internally; every control bit performs one function. Data is clocked in starting with unassigned bit 1 (UB1), followed by the remaining control bits and the DAC data byte. The LSB (D0) of the data byte is the last bit clocked into the input shift register (Figure 2).

Table 3 is an example of a 16-bit word. It performs the following functions:

1) Load 80 hex (128 decimal) into the DAC register.
2) Update the DAC output on $\overline{CS}$'s rising edge.

Table 4 shows how to calculate the output voltage based on the input code.

Low-Power, +2.5V to +5.5V, 8-Bit Voltage-Output DAC in µMAX

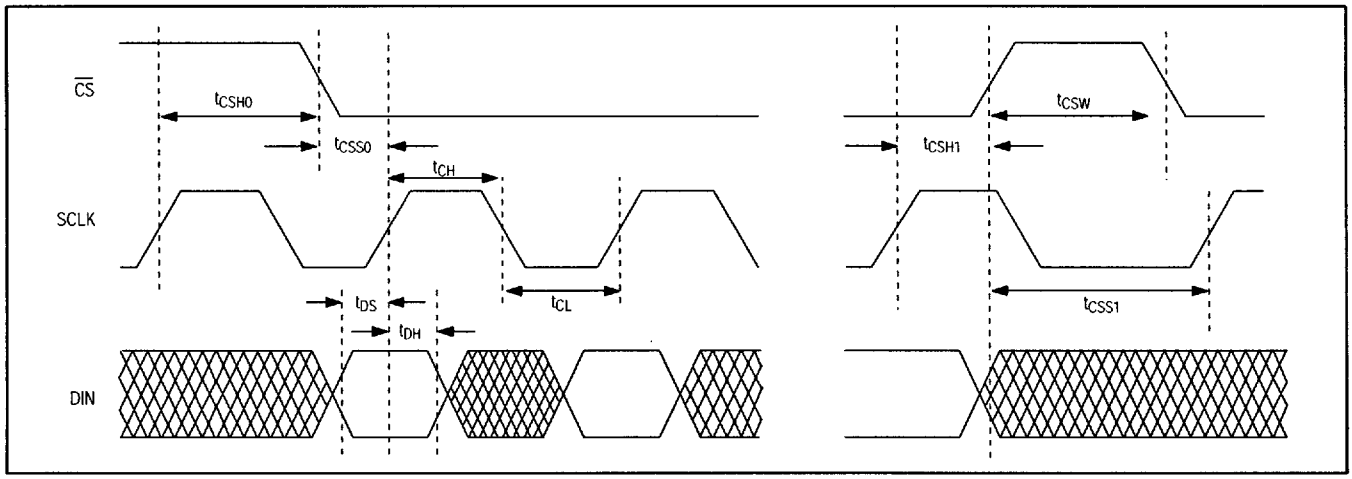


Figure 3. Detailed Serial-Interface Timing Diagram

Table 1. Control-Byte/Input-Word Bit Definitions

Control Byte	UB1*	X	Unassigned Bit 1
	UB2	X	Unassigned Bit 2
	UB3	X	Unassigned Bit 3
	C2	0	Power-Up Mode
	C2	1	Power-Down Mode
	C1	0	DAC Register Load Operation Disabled
	C1	1	DAC Register Load Operation Enabled
	C0	0	DAC Output Updated on Rising Edge of $\overline{CS}$
	C0	1	Unassigned Operation
	AB1	0	Assigned Bit 1
	AB2	1	Assigned Bit 2
Data Byte	D7	X	DAC Data Bit 7 (MSB)
	D6	X	DAC Data Bit 6
	D5	X	DAC Data Bit 5
	D4	X	DAC Data Bit 4
	D3	X	DAC Data Bit 3
	D2	X	DAC Data Bit 2
	D1	X	DAC Data Bit 1
	D0**	X	DAC Data Bit 0 (LSB)

X = Don't care
*Clocked in first
**Clocked in last

Microprocessor Interfacing

The MAX550B serial interface is compatible with Microwire, SPI, and QSPI interface standards. For SPI, clear the CPOL and CPHA bits (CPOL = 0 and CPHA = 0). CPOL = 0 sets the idle clock state to zero and CPHA = 0 changes data at SCLK's falling edge. This setting allows SPI to run at full clock speeds (1.5MHz). If a serial port is not available on your µP, three bits of a parallel port can be used to emulate a serial port by bit manipulation. Minimize digital feedthrough at the DAC output by operating the serial clock only when necessary.

Applications Information

Power-Supply and Ground Considerations

Connect GND to the highest-quality ground available. Bypass V_{DD} with a 0.1µF to 0.22µF capacitor to GND. The reference input can be used without bypassing. However, for optimum line/load-transient response and noise performance, bypass the reference input with a 0.1µF to 4.7µF capacitor to GND.

Careful PC board layout minimizes crosstalk between the DAC output, the reference, and the digital inputs. Separate analog traces by running ground traces between them. Make sure high-frequency digital lines are not routed parallel to analog lines.

Table 2. Serial-Interface Programming Commands

CONTROL BYTE								DATA BYTE								COMMAND
Loaded First								Loaded Last								
UB1	UB2	UB3	C2	C1	C0	AB1	AB2	D7	D6	D5	D4	D3	D2	D1	D0	
X	X	X	0	0	0	0	1	X	X	X	X	X	X	X	X	On $\overline{CS}$'s rising edge, wake up DAC. DAC register unchanged.
X	X	X	X	X	1	X	X	X	X	X	X	X	X	X	X	Unassigned command
X	X	X	0	1	0	0	1	8-bit DAC data								On $\overline{CS}$'s rising edge, load DAC register. Wake up DAC (if previously powered down).
X	X	X	1	0	0	0	1	X	X	X	X	X	X	X	X	On $\overline{CS}$'s rising edge, power down DAC. DAC output goes to zero. DAC register unchanged.
X	X	X	1	1	0	0	1	8-bit DAC data								On $\overline{CS}$'s rising edge, power down DAC and update DAC register. DAC output goes to zero.

X = Don't Care

Table 3. Example Input Word

Loaded First															Loaded Last
UB1	UB2	UB3	C2	C1	C0	AB1	AB2	D7	D6	D5	D4	D3	D2	D1	D0
X	X	X	0	1	0	0	1	1	0	0	0	0	0	0	0

X = Don't Care

Table 4. Analog Output vs. Code

DAC REGISTER CONTENTS								ANALOG OUTPUT (V)
D7	D6	D5	D4	D3	D2	D1	D0	
1	1	1	1	1	1	1	1	$+V_{REF}$ x (255/256)
1	0	0	0	0	0	0	1	$+V_{REF}$ x (129/256)
1	0	0	0	0	0	0	0	$+V_{REF}$ x (128/256) = $+V_{REF}/2$
0	1	1	1	1	1	1	1	$+V_{REF}$ x (127/256)
0	0	0	0	0	0	0	1	$+V_{REF}$ x (1/256)
0	0	0	0	0	0	0	0	0

Note: 1LSB = $V_{REF} \times 2^{-8} = V_{REF}(1/256)$
ANALOG OUTPUT = $+V_{REF}(I/256)$, where I = Integer Value of Digital Input and wake up DAC (if previously powered down)

Low-Power, +2.5V to +5.5V, 8-Bit Voltage-Output DAC in µMAX

AC Considerations

Digital Feedthrough

High-speed data at any of the digital input pins may couple through the DAC's internal stray capacitance and cause noise (digital feedthrough) at the DAC output, even though $\overline{CS}$ is held high. This digital feedthrough is tested by holding $\overline{CS}$ high and toggling the digital inputs from all 1s to all 0s.

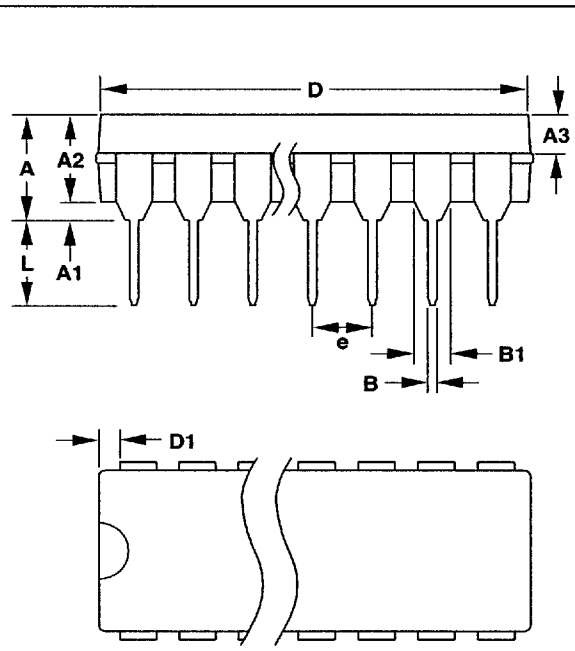
Analog Feedthrough

Due to internal stray capacitance, higher-frequency analog input signals at REF may couple to the output, even when the input digital code is all 0s. Test analog feedthrough by setting the DAC output to 0V and sweeping REF.

Chip Information

TRANSISTOR COUNT: 1562

Package Information



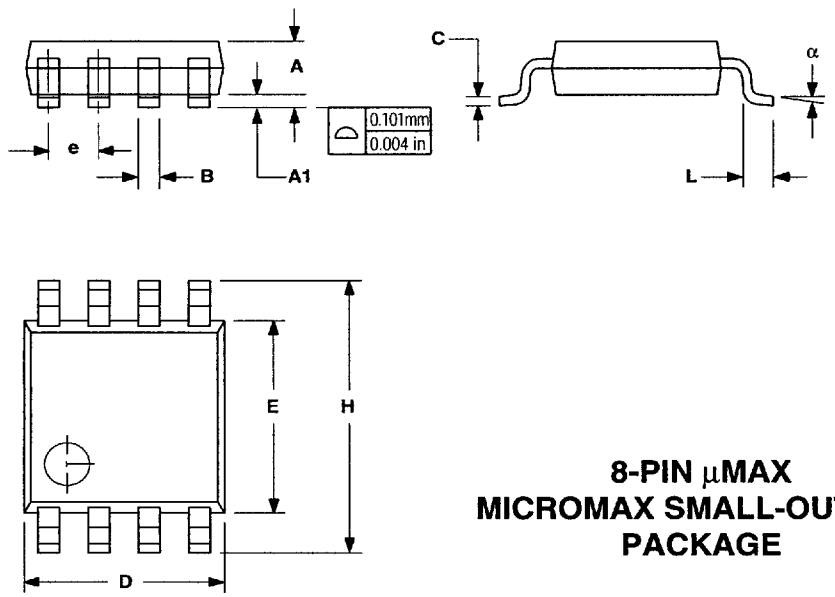
Plastic DIP
PLASTIC
DUAL-IN-LINE
PACKAGE
(0.300 in.)

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	–	0.200	–	5.08
A1	0.015	–	0.38	–
A2	0.125	0.175	3.18	4.45
A3	0.055	0.080	1.40	2.03
B	0.016	0.022	0.41	0.56
B1	0.045	0.065	1.14	1.65
C	0.008	0.012	0.20	0.30
D1	0.005	0.080	0.13	2.03
E	0.300	0.325	7.62	8.26
E1	0.240	0.310	6.10	7.87
e	0.100	–	2.54	–
eA	0.300	–	7.62	–
eB	–	0.400	–	10.16
L	0.115	0.150	2.92	3.81

PKG.	DIM	PINS	INCHES		MILLIMETERS	
			MIN	MAX	MIN	MAX
P	D	8	0.348	0.390	8.84	9.91
P	D	14	0.735	0.765	18.67	19.43
P	D	16	0.745	0.765	18.92	19.43
P	D	18	0.885	0.915	22.48	23.24
P	D	20	1.015	1.045	25.78	26.54
N	D	24	1.14	1.265	28.96	32.13

21-0043A

Package Information (continued)



DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.036	0.044	0.91	1.11
A1	0.004	0.008	0.10	0.20
B	0.010	0.014	0.25	0.36
C	0.005	0.007	0.13	0.18
D	0.116	0.120	2.95	3.05
E	0.116	0.120	2.95	3.05
e	0.0256		0.65	
H	0.188	0.198	4.78	5.03
L	0.016	0.026	0.41	0.66
α	0°	6°	0°	6°

21-0036D

8-PIN µMAX
MICROMAX SMALL-OUTLINE
PACKAGE